

**Search Notes**

Application/Control No.

10/056,005

Examiner

Kerri M. Rose

Applicant(s)/Patent under  
Reexamination

KARINO ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	229-233	10/26/2005	KMD
	235		
	236		
370	328-329	10/28/2005	KMD
	408		
Above	UPDATED	2/15/2006	KMD
455	422.1	2/15/2006	KMD
455	436	2/15/2006	KMD
Above	Updated	5/30/2006	KMD
Above	Updated	9/20/2006	KMR
Above	Udated	3/22/2007	KMR
370	216, 217	3/22/2007	KMR
370	220	3/22/2007	KMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	10/31/2005	KMD
STIC PLUS	10/27/2005	KMD
IEEE and ACM - see printout	10/28/2005	KMD
East - see printout	2/15/2006	KMD
East - see printout	5/30/2006	KMD
East - see printout	6/1/2006	KMD
Combined citation search: 2002/0194361; 2004/0095882	6/1/2006	KMD
East - see printout	9/20/2006	KMR

**Search Notes (continued)**

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(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consult with Chau Nguyen	2/15/2007	KMR